

STL75N8LF6

N-channel 80 V, 5.6 mΩ 18 A, PowerFLAT™ 5x6 STripFET™ VI DeepGATE™ Power MOSFET

Features

| Order code | V _{DSS} | R _{DS(on)} max | I _D |
|------------|------------------|----------------------------|---------------------|
| STL75N8LF6 | 80 V | $< 7.4 \ \text{m}\Omega$ | 18 A ⁽¹⁾ |

- 1. The value is rated according $R_{thj\text{-pcb}}$
- \blacksquare $R_{DS(on)} * Q_g$ industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses

Applications

Switching applications

Description

This device is an N-channel Power MOSFET developed using the 6th generation of STripFETTM DeepGATETM technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest $R_{DS(on)}$ in all packages.

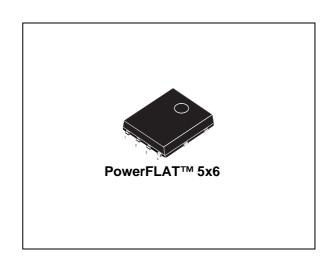


Figure 1. Internal schematic diagram

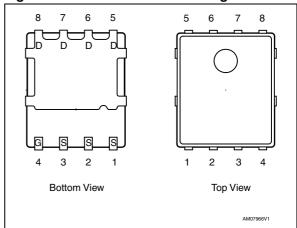


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|----------------|---------------|
| STL75N8LF6 | 75N8LF6 | PowerFLAT™ 5x6 | Tape and reel |

Contents STL75N8LF6

Contents

| 1 | Electrical ratings | . 3 |
|---|---|-----|
| 2 | Electrical characteristics | . 4 |
| | 2.1 Electrical characteristics (curves) | . 6 |
| 3 | Test circuits | . 8 |
| 4 | Package mechanical data | . 9 |
| 5 | Revision history | 13 |

STL75N8LF6 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|------------------------------------|--|------------|------|
| V _{DS} | Drain-source voltage | 80 | V |
| V _{GS} | Gate-source voltage | +20 / -16 | V |
| I _D ⁽¹⁾ | Drain current (continuous) at T _C = 25 °C | 75 | Α |
| I _D ⁽¹⁾ | Drain current (continuous) at T _C = 100 °C | 50 | Α |
| I _D ⁽²⁾ | Drain current (continuous) at T _{pcb} = 25 °C | 18 | Α |
| I _D ⁽³⁾ | Drain current (continuous) at T _{pcb} =100 °C | 11 | Α |
| I _{DM} ⁽³⁾ | Drain current (pulsed) | 72 | Α |
| P _{TOT} (1) | Total dissipation at T _C = 25 °C | 80 | W |
| P _{TOT} (3) | Total dissipation at T _{pcb} = 25 °C | 4 | W |
| | Derating factor | 0.03 | W/°C |
| T _J T _{stg} | Operating junction temperature Storage temperature | -55 to 175 | °C |

^{1.} The value is rated according to $R_{\mbox{\scriptsize thj-case}}$

Table 3. Thermal resistance

| Symbol | Parameter | Value | Unit |
|--------------------------|--|-------|------|
| R _{thj-case} | Thermal resistance junction-case (drain, steady state) | 1.56 | °C/W |
| R _{thj-pcb} (1) | Thermal resistance junction-ambient | 31.3 | °C/W |

^{1.} When mounted on FR-4 board of 1inch², 2oz Cu, t < 10 sec

Table 4. Avalanche data

| Symbol Parameter | | Value | Unit |
|------------------|--|-------|------|
| I _{AV} | Not-repetitive avalanche current, (pulse width limited by Tj Max) | 18 | Α |
| E _{AS} | Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AV}$, $V_{DD} = 50$ V) | 670 | mJ |

^{2.} The value is rated according to $R_{\mbox{\scriptsize thj-pcb}}$

^{3.} Pulse width limited by safe operating area

Electrical characteristics STL75N8LF6

2 Electrical characteristics

 $(T_{CASE} = 25 \, ^{\circ}C \text{ unless otherwise specified})$

Table 5. On/off states

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------|---|--|------|----------|------------|--------------------------|
| V _{(BR)DSS} | Drain-source breakdown voltage (V _{GS} = 0) | I _D = 250 μA | 80 | | | V |
| I _{DSS} | Zero gate voltage drain current (V _{GS} = 0) | V _{DS} = 80 V, V _{DS} = 80 V, T _C = 125 °C | | | 1 10 | μ Α μ Α |
| I _{GSS} | Gate body leakage current (V _{DS} = 0) | V _{GS} = +20 / -16 V | | | ±100 | nA |
| V _{GS(th)} | Gate threshold voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 1 | | | V |
| R _{DS(on)} | Static drain-source on resistance | V_{GS} = 10 V, I_{D} = 9 A V_{GS} = 5 V, I_{D} = 9 A | | 5.6 6 | 7.4 8.2 | mΩ |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|---|--|------|--------------------|------|----------------|
| C _{iss} C _{oss} C _{rss} | Input capacitance Output capacitance Reverse transfer capacitance | $V_{DS} = 25 \text{ V, f=1 MHz,} $ $V_{GS} = 0$ | - | 6895 516 207 | - | pF pF pF |
| Q _g Q _{gs} Q _{gd} | Total gate charge Gate-source charge Gate-drain charge | V_{DD} = 40 V, I_{D} = 18 A V_{GS} = 4.5 V (see Figure 14) | - | 51 14 17 | - | nC nC nC |
| R _G | Gate input resistance | f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain | - | 1.52 | - | Ω |

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|--|---|------|-----------------------|------|----------------------|
| t _{d(on)} t _r t _{d(off)} t _f | Turn-on delay time Rise time Turn-off delay time Fall time | V_{DD} = 40 V, I_D = 9 A, R_G = 4.7 Ω , V_{GS} =10 V (see Figure 13) | - | 17 14 112 26 | - | ns ns ns ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min | Тур. | Max | Unit |
|--|--|---|-----|-----------------|-----|---------------|
| I _{SD} | Source-drain current | | | | 18 | Α |
| I _{SDM} ⁽¹⁾ | Source-drain current (pulsed) | | - | | 72 | Α |
| V _{SD} ⁽²⁾ | Forward on voltage | I _{SD} = 18 A, V _{GS} =0 | - | | 1.1 | V |
| t _{rr} Q _{rr} I _{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 18 \text{ A},$ $di/dt = 100 \text{ A/}\mu\text{s},$ $V_{DD} = 63 \text{ V}$ | - | 37 49 2.7 | | ns nC A |

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STL75N8LF6

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

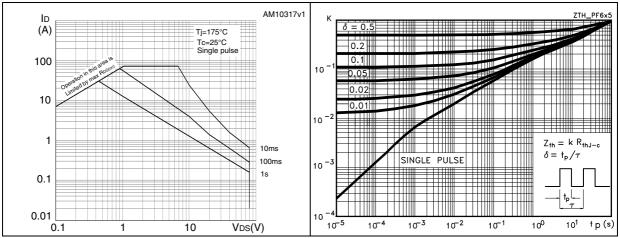


Figure 4. Output characteristics

Figure 5. Transfer characteristics

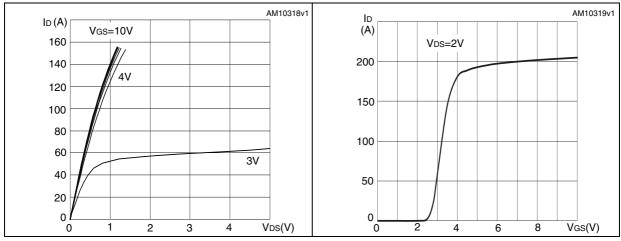
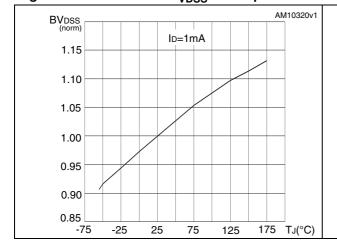
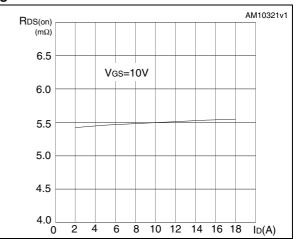


Figure 6. Normalized B_{VDSS} vs temperature Figure 7. Static drain-source on resistance





AM10322v1 AM10323v1 Vgs C (pF) (V) 9000 VDD=40V 10 ID=18A 8000 Ciss 8 7000 6000 6 4000 Coss 3000 4 Crss 2000 2 1000 0 Qg(nC) 0.1 20 40 60 80 100 10 100 VDS(V)

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature temperature

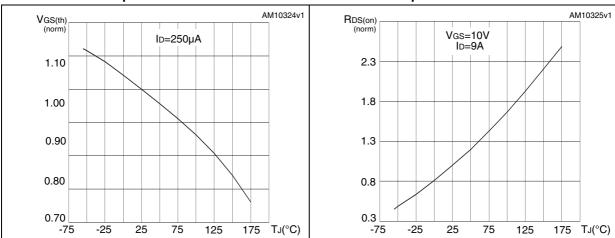
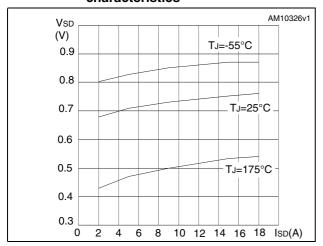


Figure 12. Source-drain diode forward characteristics



Test circuits STL75N8LF6

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

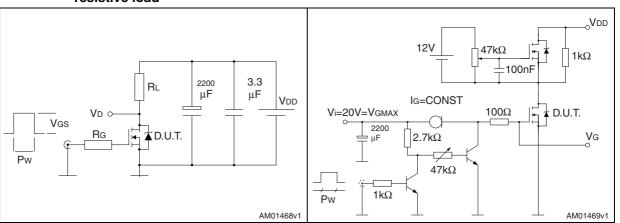


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

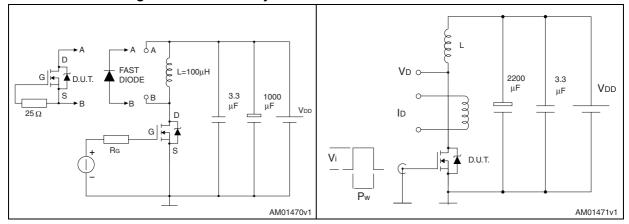
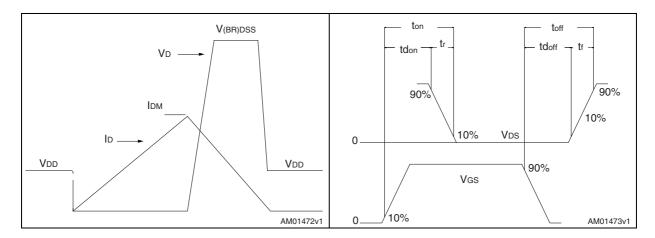


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



57

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 9. PowerFLAT™ 5x6 type C-B mechanical data

| Dim. | | mm | |
|--------|------|------|------|
| Dilli. | Min. | Тур. | Max. |
| Α | 0.80 | 0.83 | 0.93 |
| A1 | 0 | 0.02 | 0.05 |
| A3 | | 0.20 | |
| b | 0.35 | 0.40 | 0.47 |
| D | | 5.00 | |
| D1 | | 4.75 | |
| D2 | 4.15 | 4.20 | 4.25 |
| E | | 6.00 | |
| E1 | | 5.75 | |
| E2 | 3.43 | 3.48 | 3.53 |
| E4 | 2.58 | 2.63 | 2.68 |
| е | | 1.27 | |
| L | 0.70 | 0.80 | 0.90 |

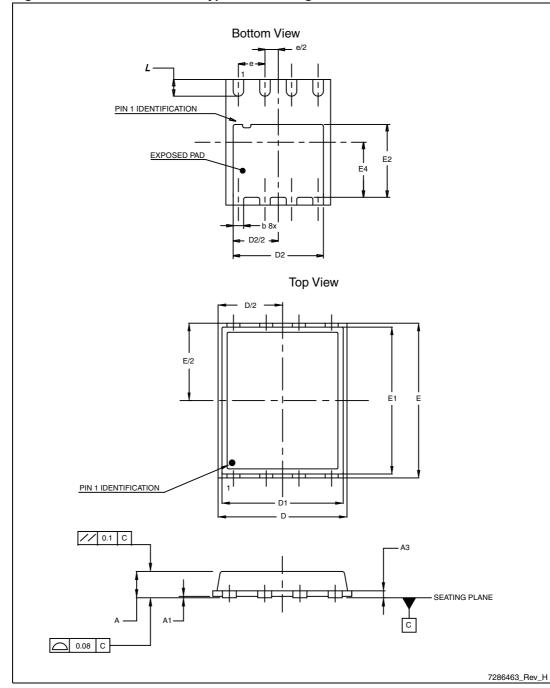


Figure 19. PowerFLAT™ 5x6 type C-B drawing

Table 10. PowerFLAT™ 5x6 type S-C mechanical data

| Dim. | mm | | | |
|------|-------|------|-------|--|
| Dim. | Min. | Тур. | Max. | |
| Α | 0.80 | | 1.00 | |
| A1 | 0.02 | | 0.05 | |
| A2 | | 0.25 | | |
| b | 0.30 | | 0.50 | |
| D | | 5.20 | | |
| E | | 6.15 | | |
| D2 | 4.11 | | 4.31 | |
| E2 | 3.50 | | 3.70 | |
| е | | 1.27 | | |
| e1 | | 0.65 | | |
| L | 0.715 | | 1.015 | |
| K | 1.05 | | 1.35 | |

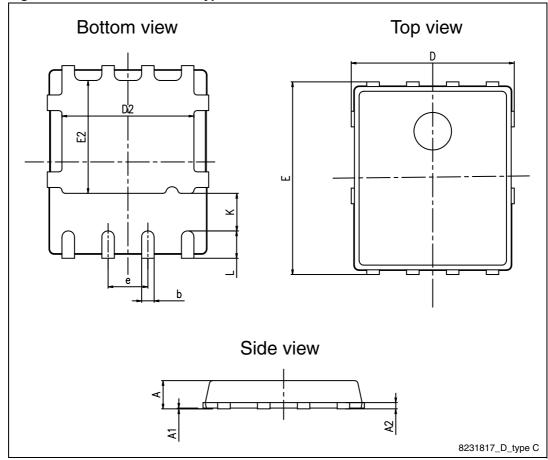


Figure 20. PowerFLAT™ 5x6 type S-C mechanical data

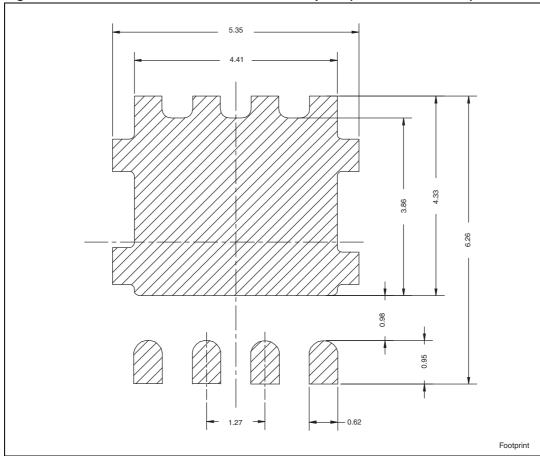


Figure 21. PowerFLAT™ 5x6 recommended footprint (dimensions in mm)

STL75N8LF6 Revision history

5 Revision history

Table 11. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 11-May-2011 | 1 | First release. |
| 08-Jul-2011 | 2 | Document status promoted from preliminary data to datasheet. |
| 10-Nov-2011 | 3 | Section 4: Package mechanical data has been updated. |

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY TWO AUTHORIZED ST REPRESENTATIVES, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2011 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

16/16 Doc ID 018820 Rev 3



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

STMicroelectronics: STL75N8LF6